Applicant(s)/Patent Under Application/Control No. Reexamination 10/644,065 TAKAE ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 2681 David Q. Nguyen **U.S. PATENT DOCUMENTS** Document Number Date Classification Name Country Code-Number-Kind Code MM-YYYY 439/60 US-6,669,487 B1 12-2003 Nishizawa et al. Α US-В US-С US-D US-Ε US-F US-G US-Н US-US-J US-Κ US-L US-М **FOREIGN PATENT DOCUMENTS** Document Number Date Name Classification Country Country Code-Number-Kind Code MM-YYYY Ν 0 Р Q R s T **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U W

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